

<b>Search Notes</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/767,039	FURUKAWA ET AL.
	Examiner Phat X. Cao	Art Unit 2814

<b>INTERFERENCE SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>